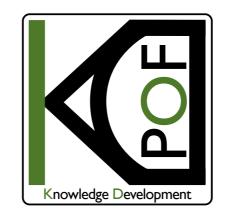


BASE-AU 980nm/OM3 baseline Definition of the optical parameters and test methods

Rubén Pérez-Aranda, KDPOF



Clock recovery unit (CRU)

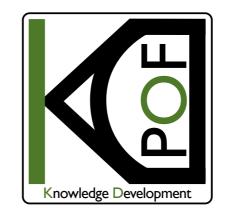
CRU (clock recovery unit) specification



- CRU is going to be used in some test setups to generate a low jitter clock recovered from the transmitter signal under test, to be used as input trigger signal to a pattern triggered oscilloscope
- The CRU OJTF (observed jitter transfer function) needs to be specified according to the communications system requirements (TX and RX)
- BASE-AU PHYs support optional EEE capability, as specified in 802.3cz/D1.2, where RS-FEC CWs are replaced with Refresh CWs during LPI operation, which are used by the link partner to keep the receiver aligned while power consumption can be reduced
- As stated in [1], after detected LPI, while receiving Refresh codewords, the receiver only needs to sample, equalize and detect a small portion of symbols of each CW (last n 65-bit blocks plus the first m repeated 20-bit PHD sub-blocks for Wake detection and robust decoding of PHD)
- Both clocks, TX and RX, should experience small deviation during Refresh CW transmission. The minimum clock recovery actuation period is equivalent to a CW (5440 bits) transmission time
 - For 50 Gb/s, CW transmission time = 108.8 ns
 - For 2.5 Gb/s, CW transmission time = 2176 ns
- In order to simplify clock recovery implementation, a CRU corner frequency of less one fourth the CW transmission rate is proposed:
 - For 50 Gb/s: $f_{CRU}\simeq 2~MHz$
 - + For 2.5 Gb/s: $f_{CRU}\simeq 100 \; kHz$
- Multi-rate BASE-AU PHYs implementation is expected, all the rates using a common PLL, so the low frequency jitter characteristic will be common. Therefore, a single corner is proposed:

The clock recovery unit (CRU) shall have a corner frequency of 0.1 MHz and a slope of 20 dB/decade. The CRU can be implemented in hardware or software depending on oscilloscope technology.

• This specification applies to all the test-setups where CRU is used



Test patterns

Test patterns for PMD validation



- Normal operation
- BER test mode operation

• SSPR-NRZ: short stress pattern random for NRZ scheme

- SSPR defined by IA OIF-CEI-4.0 has been used by the industry to replace PRBS31, allowing shorter test time with baseline wander and clock wander statistically at least as stressful as 10.000 years of random binary
- SSPR uses PRBS28, with several initialisation seeds, differential encoding, and CID sequences of 72 0's or 72 1's
- Proposed SSPR-NRZ reuses most part of OIF SSPR (polynomials, seeds, differential encoding), however it limits to a
 maximum of 31 continuous 0's and 1's.

• SSPR-PAM4: short stress pattern random for PAM4 scheme

- SSPRQ defined in 802.3 C/120 has been adopted for PAM4 PMD testing
- SSPRQ design followed similar considerations of OIF SSPR about baseline and clock wanders
- Proposed SSPR-PAM4 reuses most part of C/120 SSPRQ (polynomials, seeds, etc), however it uses the PAM4 mapper in C/166 of 802.3cz D1.2, the sequence length is even, max CID length for all the digits is the same

• SSQWP: slow square wave pattern:

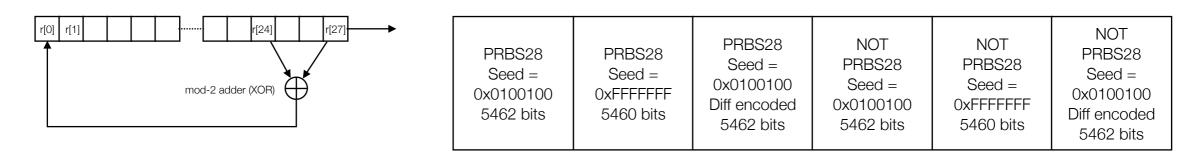
- PMA generates a square wave test pattern: n_{sq} {+1} followed by n_{sq} {-1} toward the service interface PMD_COMSIGNAL.request, where parameter n_{sq} depends on PHY rate:
 - 50GBASE-AU and 25GBASE-AU, $n_{sq} = 16$,
 - 10GBASE-AU, $n_{sq} = 8$,
 - 5GBASE-AU, $n_{sq} = 4$,
 - 2.5GBASE-AU, $n_{sq} = 4$

• FSQWP: fast square wave pattern:

• PMA generates a square wave test pattern with $n_{sq} = 1$

Test patterns for PMD validation: SSPR-NRZ

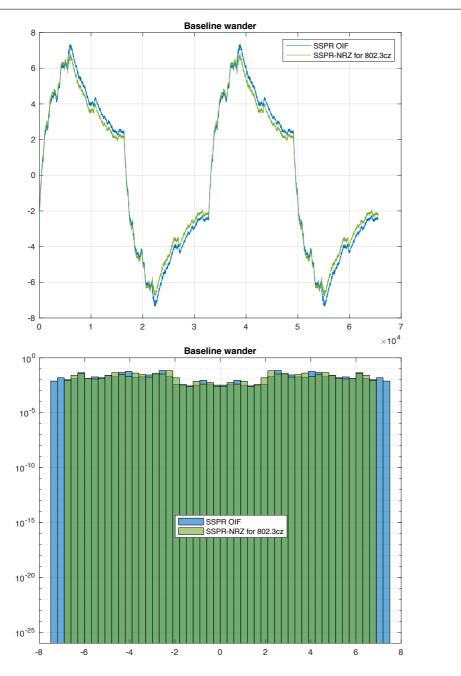


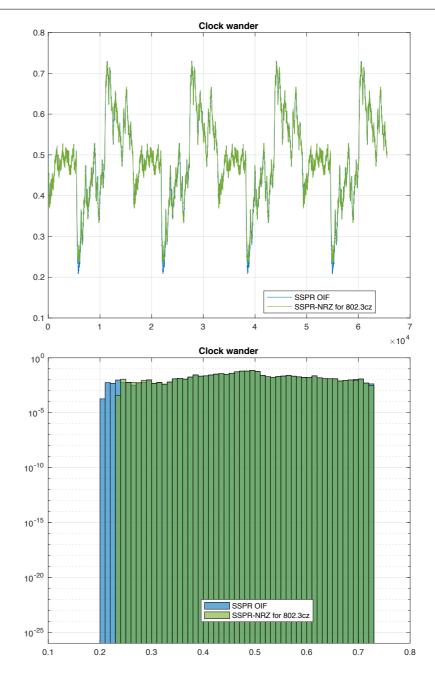


- Total length 32768 NRZ symbols
- Block 1 is 5462 bits of PRBS28 seed = 0x0100100 and begins with 8 x 0, 1, 11 x 0, 1, 12 x 0, 1 ...
- Block 2 is 5460 bits of PRBS28 seed = 0xFFFFFF and begins with 28 x 1, 25 x 0, 3 x 1, 22 x 0 ...
- Block 3 takes the same sequence as block 1 and encodes it as follows:
 - A zero causes a change of the output
 - A one causes no change of output
 - The output before the first bit is assumed to have been zero
- Blocks 4 to 6 are the binary inverse of blocks 1 to 3 respectively
- Leftmost hexadecimal digit of a seed corresponds to the initial value of register element r[0]. Therefore, the rightmost bit of the rightmost digit corresponds to the initial value of register element r[27].
- The initial value of r[27] is the first bit generated by the LFSR for each initialisation
- The binary sequence is mapped by PMA transmit function to {-1, +1} symbols as specified in 802.3cz/ D1.2, Table 166-5 for parameter G = 1.

Test patterns for PMD validation: SSPR-NRZ



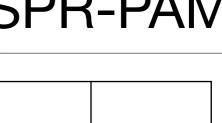




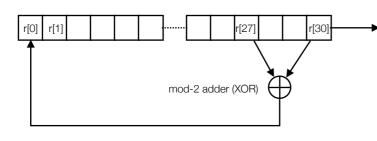


Same considerations of [3]. Baseline wander was assessed with a cut-off frequency of baudrate/10000 and clock content was assessed with a corner frequency of baudrate/1667. From [3], baseline wander limit that will be exceeded only once in 10000 years (10 years, 1000 random streams) at 10 Gb/s is +/- 6.8%. Limits for clock wander are [0.3, 0.7]. For 25 Gb/s, it is equivalent to 4000 years.

Test patterns for PMD validation: SSPR-PAM4





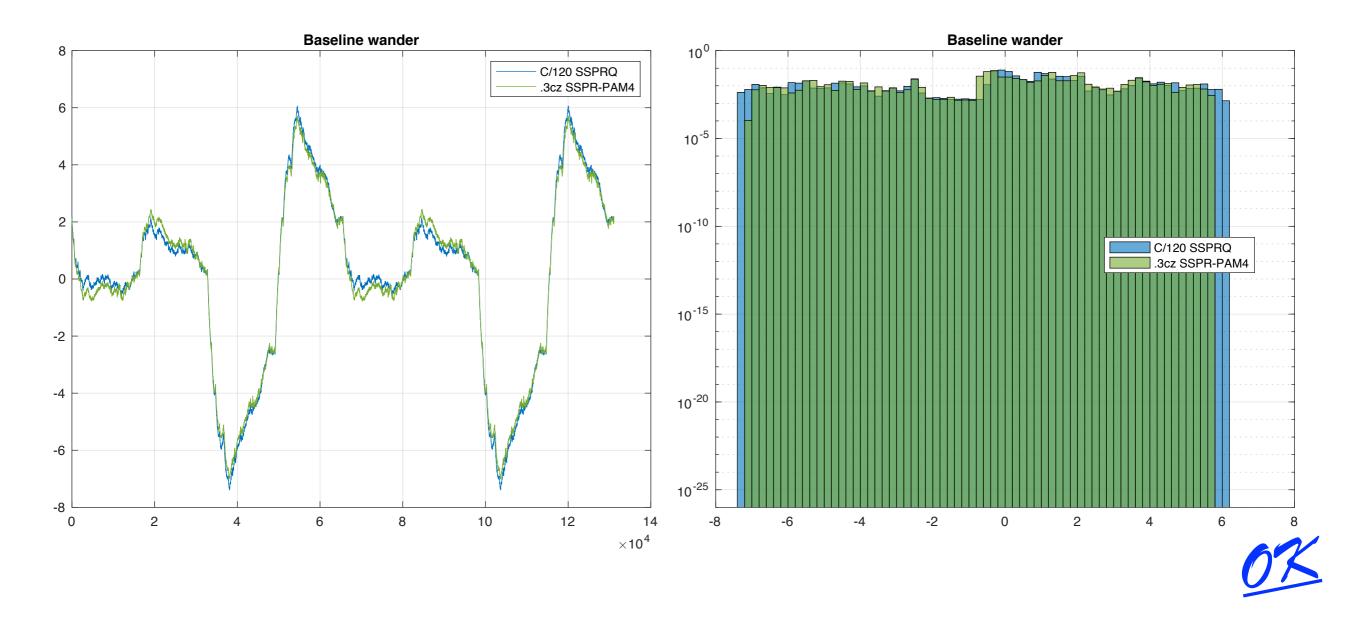


Block S1	S2 = -S1	Block S3	Block S4
16384 PAM4		16383 PAM4	16385 PAM4
symbols		symbols	symbols

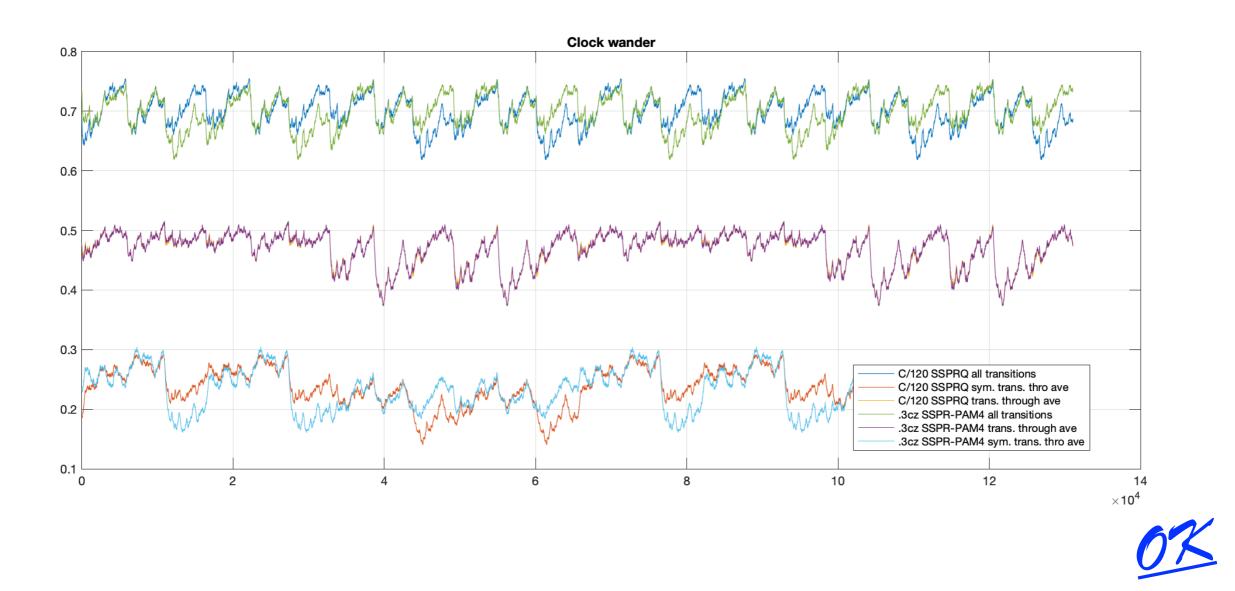
- Total length 65536 PAM4 symbols
- Block A1 is 10924 bits of PRBS31 seed = 0x2000000 and begins with 29 x 0, 1, 27 x 0, 1, 0, 0, 1, 24 x 0, 1, 5 x 0, 1 ...
- Block A2 is 10922 bits of PRBS31 seed = 0x77FE4016 and begins with 0, 1, 1, 0, 1, 9 x 0, 1, 0, 0, 10 x 1 ...
- 0, 1, 1, 0, 0, 1 ...
- Block A is the binary inverse of the concatenation of A1, A2, A3
- Block B is a 65536-bit length sequence formed by removing the first bit from a sequence consisting of two repetitions of binary block A and appending a bit = 0 to the end
- Leftmost hexadecimal digit of a seed corresponds to the initial value of register element r[0]. Therefore, the rightmost bit of the rightmost digit corresponds to the initial value of register element r[30].
- The initial value of r[30] is the first bit generated by the LFSR for each initialisation
- The binary block A is PAM4 mapped by PMA transmit function to {-1, -1/3, +1/3, +1} symbols as specified in 802.3cz/D1.2, Table 166-5 for parameter G = 2, to form 16384-symbol block S1
- 16384-symbol block S2 is generated from block S1 inverting the sign for each symbol
- 16383-symbol block S3 results from PAM4 mapping of the first 32766 bits of the binary block B
- 16385-symbol block S4 results from PAM4 mapping of the last 32770 bits of the binary block B, and inverting the sign of each PAM4 symbol

Test patterns for PMD validation: SSPR-PAM4



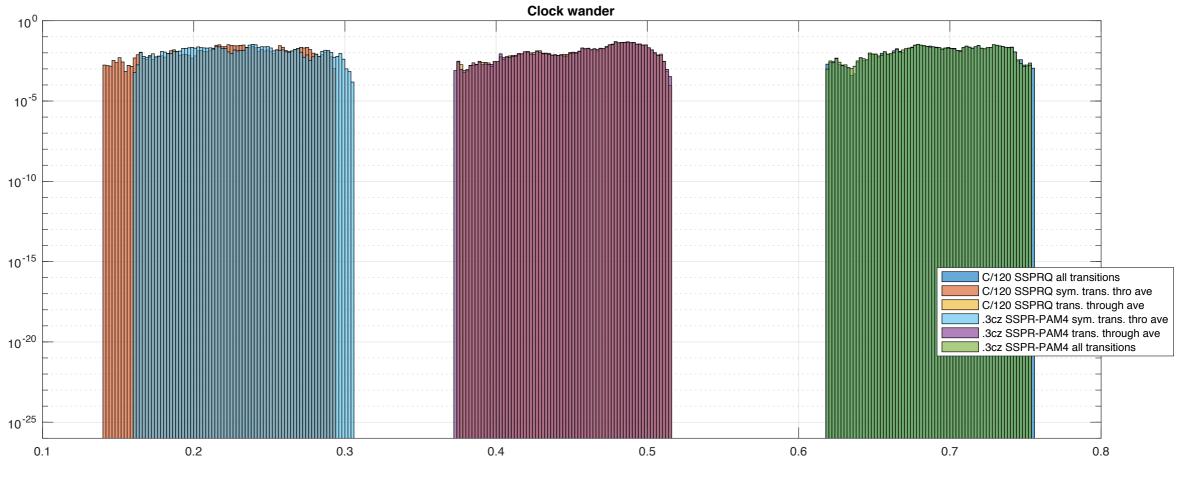


Same considerations of [4]. Baseline wander was assessed with a cut-off frequency of baudrate/10000. From [4], baseline wander limit that will be exceeded only once in 10000 years at 50 Gb/s random stream is +/- 5.2%.



Same considerations of [4]. Clock wanders for the three types of transitions were assessed with corner frequency of baudrate/6641. From [4], clock wander limits that will be exceeded only once in 10000 years at 50 Gb/s of random stream are: [0.16, 0.34] for symmetric transitions through average, [0.39, 0.60] for transitions through average, [0.84] for all the transitions.

Test patterns for PMD validation: SSPR-PAM4



07

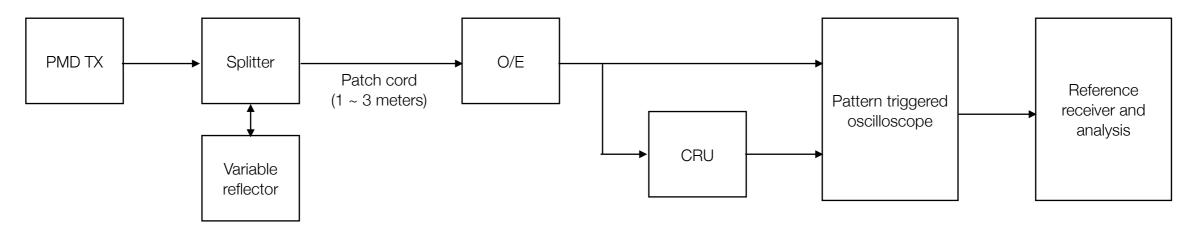
Same considerations of [4]. Clock wanders for the three types of transitions were assessed with corner frequency of baudrate/6641. From [4], clock wander limits that will be exceeded only once in 10000 years at 50 Gb/s of random stream are: [0.16, 0.34] for symmetric transitions through average, [0.39, 0.60] for transitions through average, [0.84] for all the transitions.



Parameters and test methods

TDFOM setup and test method

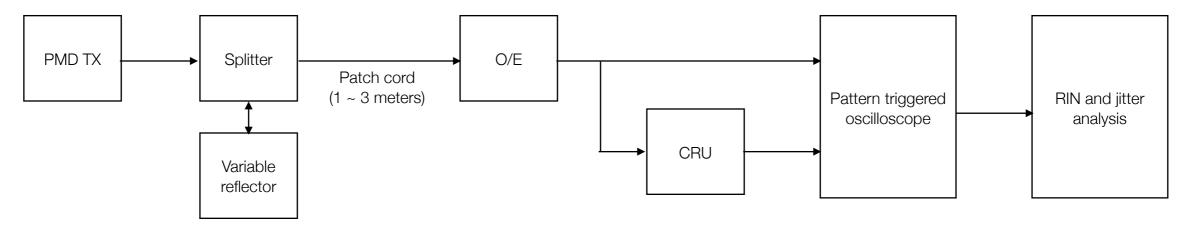




- PHY TX under test is configured to generate SSPR-NRZ (for 25, 10, 5, 2.5 Gb/s operation of a BASE-AU PHY) or SSPR-PAM4 (for 50GBASE-AU)
- Variable reflector is adjusted to generate optical return loss equal to the max value specified of 12 dB
- Equivalent response of O/E converter plus oscilloscope is configured as specified in [2]
- Reference receiver and analysis specified in [2] is used to calculate TDFOM, and optionally OMA, ER and AOP

OMA, ER, RIN and tJ. Setup and test method





- SSQWP is generated by the PHY TX under test
- Variable reflector is adjusted to generate optical return loss equal to the max value specified of 12 dB
- Equivalent response of O/E plus oscilloscope is configured to be 4th order Bessel-Thomson low pass filter with BW_{-3dB} as following. Equivalent noise bandwidth is $BW_n = 1.04 \cdot BW_{-3dB}$
 - $BW_{-3dB} = 20 \text{ GHz}$ for 25GBASE-AU and 50GBASE-AU
 - $BW_{-3dB} = 8 \text{ GHz}$ for 10GBASE-AU
 - $BW_{-3dB} = 4 GHz$ for 5GBASE-AU
 - $BW_{-3dB} = 2 GHz$ for 2.5GBASE-AU
- P₁ is measured as the mean value of signal over the center 3% of the time interval where the signal is in the high state
- P_0 is measured as the mean value of signal over the center 3% of the time interval where the signal is in the low state
- RN₁ is measured as the standard deviation of signal over the same interval where P₁ is measured
- RN₀ is measured as the standard deviation of signal over the same interval where P₀ is measured

- Uncorrelated random jitter is measured in rise and fall edges using two horizontal measurement windows placed at the average power level of the pattern with a height of 2% (P₁ - P₀)
 - Standard deviations of both distributions are the random jitter in rise edge $\sigma_{\text{rise}},$ and fall edge $\sigma_{\text{fall}}.$
- OMA, ER, and RIN₁₂OMA are defined as:

$$OMA = P_1 - P_0 \text{ (watts);}$$

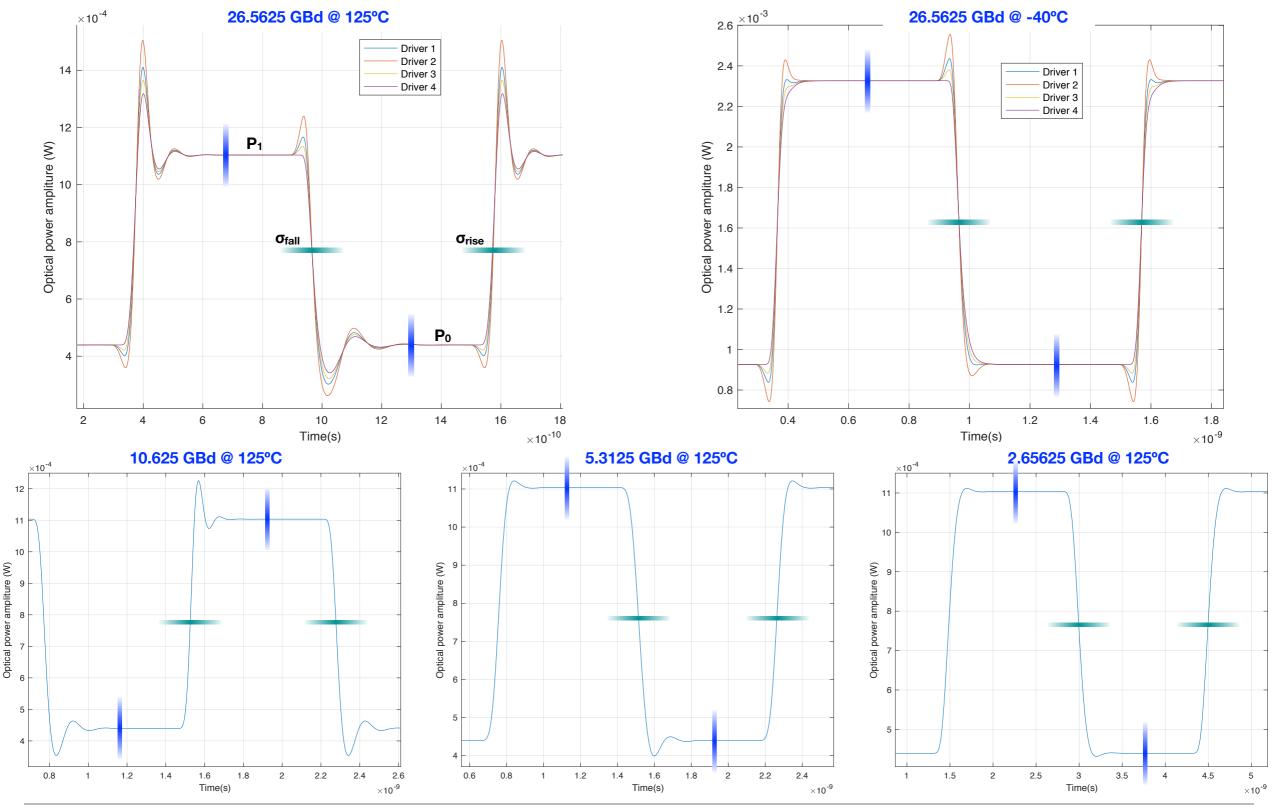
$$ER = 10 \cdot \log_{10} \left(\frac{P_1}{P_0} \right) \text{ (dB);}$$

$$RIN_{12}OMA = 10 \cdot \log_{10} \left(\frac{\left(RN_1 + RN_0 \right)^2}{OMA^2 \cdot BW_N} \right) \text{ (dB/Hz)}$$

- Random jitter is defined as: $t_J = \sqrt{\left(\sigma_{rise}^2 + \sigma_{fall}^2\right)/2}$
- Alternatively, OMA and ER can also be measured as defined in TDFOM method in [2]
- Alternatively, random jitter can also be measured with FSQWP

OMA, ER, RIN and t_J — illustration for different rates



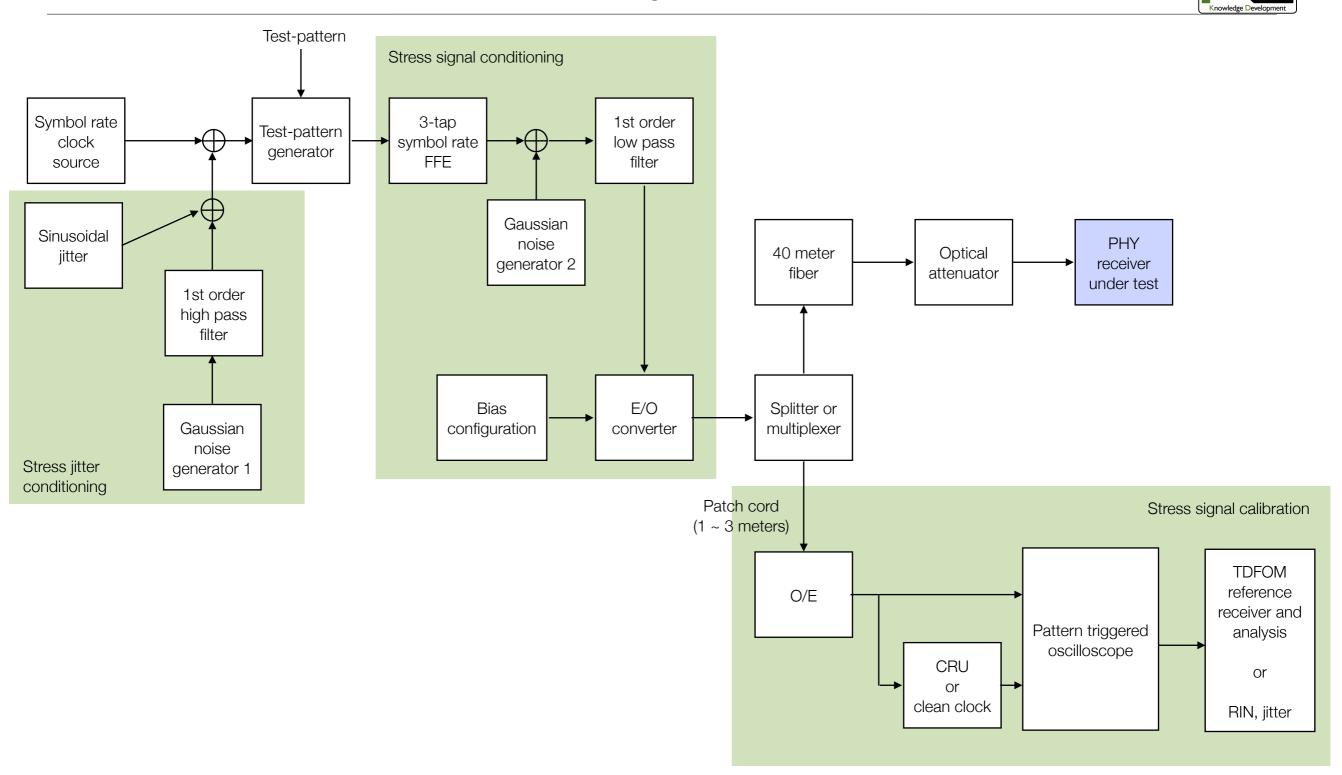






- The center wavelength and RMS spectral width shall be within the specified range measured per IEC 61280-1-3. The center wavelength and RMS spectral width are measured with the PHY generating SSPR-NRZ, SSPR-PAM4 or in normal transmission
- The average optical power (AOP) shall be within the specify limits measured using the methods given in IEC 61280-1-1. The average optical power is measured with the PHY generating SSPR-NRZ, SSPR-PAM4 or in normal transmission
- Alternatively, AOP can also be measured as defined in TDFOM method in [2]

Stress receiver sensitivity test setup



Stress receiver sensitivity method



- Step 0 preconditioning
 - Gaussian noise generators and sinusoidal jitter generator are turned off
- Step 1 stress signal conditioning calibration (TDFOM and ER)
 - Test pattern generator is programmed to generate continuously SSPR-NRZ (for 25, 10, 5, 2.5 Gb/s) or SSPR-PAM4 (for 50Gb/s) with symbol rate in the specified limits
 - E/O converter produces optical signal with spectral characteristics under the specified limits
 - E/O converter is connected to O/E converter, CRU, oscilloscope, reference receiver and TDFOM analysis block as specified in [2]
 - Bias, 1st order low pass filter and FFE are adjusted to get receiver test TDFOM condition
 - E/O bias can be used to speed-up or slow-down the optical signal, so decreasing or increasing TDFOM. E/O bias can be reduced, provided that RIN and jitter specifications are met
 - 1st order low pass filter bandwidth can also be adjusted to produce ISI, so increasing TDFOM
 - The 3-tap symbol-rate FFE with coefficients [-a, (1+2a), -a], the parameter a can be adjusted to produce peaking close to Nyquist frequency (resonance emulation), so decreasing TDFOM
 - Modulation amplitude of test pattern generator is adjusted to obtain min ER condition

- Record OMA to AOP ratio Γ_{μ}
- Step 2 stress signal conditioning calibration (RIN and jitter)
 - Test pattern generator is programmed to generate continuously SSQWP with symbol rate in the specified limits
 - O/E plus oscilloscope is configured for RIN and jitter analysis
 - Sinusoidal jitter is adjusted according to the table for the selected frequency, and using a clean clock in place of the CRU to trigger the oscilloscope
 - 1st order high pass filter is set for -3dB bandwidth of 200 kHz, and gaussian noise generator 1 is adjusted in amplitude to obtain max uncorrelated random jitter condition
 - Gaussian noise generator 2 is adjusted in amplitude to obtain max RINOMA condition
- Step 3 stress signal conditioning calibration (TDFOM refinement)
 - With the same setup of step 1, FFE and low pass filter will be refined to get the objective TDFOM

Applied sinusoidal jitter

	Sinusoidal jitter peak-to-peak (UI)	
Frequency range	25, 10, 5, 2.5 Gb/s	50 Gb/s
f < 1 kHz	Not specified	Not specified
$1 \text{ kHz} \le f \le 100 \text{ kHz}$	15000/f	6000/f
100 kHz < f ≤ 200 kHz	0.15	0.06
f > 200 kHz	0	0

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Stress receiver sensitivity method

- Step 4 stress receiver sensitivity measurement
 - Test pattern generator is programmed to generate continuously normal transmit block in BER test mode configuration with symbol rate in the specified limits, with the following PHD content:
 - PHD.TX.NEXT.MODE = 1
 - PHD.RX.LINKSTATUS = 1
 - PHD.RX.HDRSTATUS = 1
 - PHD.RX.LINKMARGIN = 0x7F
 - PHD.CAP.LPI = 0
 - PHD.CAP.OAM = 0
 - All the PHD.OAM fields = 0
 - E/O converter is connected to the receiver through 40 meters of OM3 fiber and optical attenuator configuration for minimum attenuation
 - Optical attenuation is increased until PHY RX under test reports one of the following conditions:
 - RFER is over the limit. RFER is calculated as the ratio of BASE-U PCS status 5 register RS-FEC codeword error counter and number of RS-FEC CWs transmitted during the time between BASE-U PCS status 5 register readings

- Local link margin reported in BASE-U PCS status 2 register is < 0
- BASE-U PCS status 1 register reports Local receiver status = 0, or Link status = 0, or Local PHD reception status = 0, or PHD lock status =
- Optical attenuation is increased is small steps until none of the above conditions are met
- Receiver sensitivity OMA can be measured in one of the following three ways:
 - AOP at TP3 is measured, and OMA at TP3 calculated as $OMA_{TP3} = AOP_{TP3} \cdot \Gamma_{Tr}$
 - OMA at TP3 is directly measured using SSQWP pattern, TP3 connected to O/E and oscilloscope configured for RIN and jitter analysis
 - OMA at TP3 is directly measured using SSPR-NRZ or SSPR-PAM4 pattern, TP3 connected to O/E and oscilloscope configured for TDFOM analysis
- Steps 1 to 4 are carried out for the two stress conditions (1 and 2)



Parameters and test patterns relation



Parameters and related test-patterns

Parameter	Pattern	
Wavelength, spectral width. 50 Gb/s	SSPR-PAM4 or valid 50GBASE-AU signal	
Wavelength, spectral width. 25, 10, 5, 2.5 Gb/s	SSPR-NRZ or valid 25GBASE-AU, 10GBASE-AU, 5GBASE-AU or 2.5GBASE-AU signal	
Average optical power (AOP). 50 Gb/s	SSPR-PAM4 or valid 50GBASE-AU signal	
Average optical power (AOP). 25, 10, 5, 2.5 Gb/s	SSPR-NRZ or valid 25GBASE-AU, 10GBASE-AU, 5GBASE-AU or 2.5GBASE-AU signal	
Optical modulation amplitude (OMA). 50 Gb/s	SSPR-PAM4, SSQWP	
Optical modulation amplitude(OMA). 25, 10, 5, 2.5 Gb/s	SSPR-NRZ, SSQWP	
Transmitter and distortion figure of merit (TDFOM). 50 Gb/s	SSPR-PAM4	
Transmitter and distortion figure of merit (TDFOM). 25, 10, 5, 2.5 Gb/s	SSPR-NRZ	
Extinction ratio (ER). 50 Gb/s	SSPR-PAM4, SSQWP	
Extinction ratio (ER). 25, 10, 5, 2.5 Gb/s	SSPR-NRZ, SSQWP	
Relative intensity noise (RIN ₁₂ OMA)	SSQWP	
Uncorrelated random jitter (t,)	SSQWP, FSQWP	
Stress receiver sensitivity	valid 50GBASE-AU, 25GBASE-AU, 10GBASE-AU, 5GBASE-AU or 2.5GBASE-AU signat, operating in BER test mode or normal mode	
Stress receiver calibration. 50 Gb/s	SSPR-PAM4	
Stress receiver calibration. 25, 10, 5, 2.5 Gb/s	SSPR-NRZ	

Conclusions

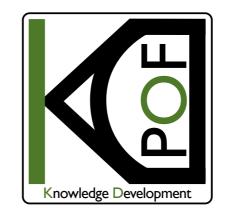


- Definition of the optical parameters and test methods have been provided for BASE-AU 980nm/OM3
- These are proposed to be included in the BASE-AU 980nm/OM3 PMD baseline

References



- [1] R. Pérez-Aranda, "BASE-U EEE proposal," July 2021, [Online], Available: <u>https://www.ieee802.org/3/cz/public/jul_2021/</u> perezaranda_3cz_04_0721_eee.pdf
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- [3] P. Anslow et al., "CEI Short Stress Patterns White Paper," Optical Internetworking Forum (OIF)
- [4] P. Anslow, "SSPR generation," October 2016, [Online], Available: <u>https://grouper.ieee.org/groups/802/3/bs/public/adhoc/logic/oct27_16/anslow_02a_1016_logic.pdf</u>



Thank you